# ANALOG DEVICES

# 3 V, Parallel Input Micropower 10-/12-Bit DACs
## AD7392/AD7393

## FEATURES

**Micropower: 100 µA**
**0.1 µA typical power shutdown**
**Single-supply 2.7 V to 5.5 V operation**
**AD7392: 12-bit resolution**
**AD7393: 10-bit resolution**
**0.9 LSB differential nonlinearity error**

## APPLICATIONS

**Automotive 0.5 V to 4.5 V output span voltage**
**Portable communications**
**Digitally controlled calibration**
**PC peripherals**

## GENERAL DESCRIPTION

The AD7392/AD7393 comprise a set of pin-compatible 10-/12-bit voltage output, digital-to-analog converters. The parts are designed to operate from a single 3 V supply. Built using a CBCMOS process, these monolithic DACs offer low cost and ease of use in single-supply 3 V systems. Operation is guaranteed over the supply voltage range of 2.7 V to 5.5 V, making this device ideal for battery-operated applications.

The full-scale voltage output is determined by the external reference input voltage applied. The rail-to-rail $REF_{IN}$ to $DAC_{OUT}$ allows a full-scale voltage equal to the positive supply $V_{DD}$ or any value in between. The voltage outputs are capable of sourcing 5 mA.

A data latch load of 12 bits with a 45 ns write time eliminates wait states when interfacing to the fastest processors. Additionally, an asynchronous $\overline{RS}$ input sets the output to a zero scale at power-on or upon user demand.

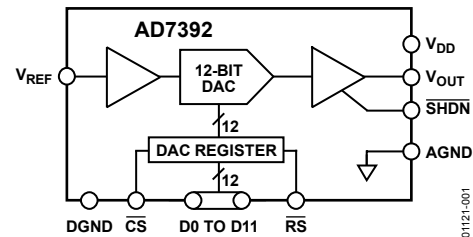## FUNCTIONAL BLOCK DIAGRAM



*Figure 1.*

Both parts are offered with similar pinouts, which allows users to select the amount of resolution appropriate for their applications without changing the circuit card.

The AD7392/AD7393 are specified for operation over the extended industrial temperature range of −40°C to +85°C. The AD7393AR is specified for the automotive temperature range of −40°C to +125°C. The AD7392/AD7393 are available in 20-lead PDIP and 20-lead SOIC packages.

For serial data input, 8-lead packaged versions, see the AD7390 and AD7391.

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# SPECIFICATIONS

## ELECTRICAL CHARACTERISTICS

At $V_{REF}$ = 2.5 V, −40°C < $T_A$ < +85°C, unless otherwise noted.

**Table 1. AD7392**

| Parameter | Symbol | Conditions | 3 V ± 10% | 5 V ± 10% | Unit |
|---|---|---|---|---|---|
| STATIC PERFORMANCE | | | | | |
| Resolution[1] | N | | 12 | 12 | Bits |
| Relative Accuracy[2] | INL | $T_A$ = +25°C | ±1.8 | ±1.8 | LSB max |
| | | $T_A$ = −40°C, +85°C | ±3 | ±3 | LSB max |
| Differential Nonlinearity[2] | DNL | $T_A$ = +25°C, monotonic | ±0.9 | ±0.9 | LSB max |
| | | Monotonic | ±1 | ±1 | LSB max |
| Zero-Scale Error | $V_{ZSE}$ | Data = 0x000, $T_A$ = +25°C, +85°C | 4.0 | 4.0 | mV max |
| | | Data = 0x000, $T_A$ = −40°C | 8.0 | 8.0 | mV max |
| Full-Scale Voltage Error | $V_{FSE}$ | $T_A$ = +25°C, +85°C, data = 0xFFF | ±8 | ±8 | mV max |
| | | $T_A$ = −40°C, data = 0xFFF | ±20 | ±20 | mV max |
| Full-Scale Temperature Coefficient[3] | $TCV_{FS}$ | | 28 | 28 | ppm/°C typ |
| REFERENCE INPUT | | | | | |
| $V_{REF}$ Range | $V_{REF}$ | | 0/$V_{DD}$ | 0/$V_{DD}$ | V min/max |
| Input Resistance | $R_{REF}$ | | 2.5 | 2.5 | MΩ typ[4] |
| Input Capacitance[3] | $C_{REF}$ | | 5 | 5 | pF typ |
| ANALOG OUTPUT | | | | | |
| Current (Source) | $I_{OUT}$ | Data = 0x800, Δ $V_{OUT}$ = 5 LSB | 1 | 1 | mA typ |
| Output Current (Sink) | $I_{OUT}$ | Data = 0x800, Δ $V_{OUT}$ = 5 LSB | 3 | 3 | mA typ |
| Capacitive Load[3] | $C_L$ | No oscillation | 100 | 100 | pF typ |
| LOGIC INPUTS | | | | | |
| Logic Input Low Voltage | $V_{IL}$ | | 0.5 | 0.8 | V max |
| Logic Input High Voltage | $V_{IH}$ | | $V_{DD}$ − 0.6 | $V_{DD}$ − 0.6 | V min |
| Input Leakage Current | $I_{IL}$ | | 10 | 10 | µA max |
| Input Capacitance[3] | $C_{IL}$ | | 10 | 10 | pF max |
| INTERFACE TIMING[3, 5] | | | | | |
| Chip Select Write Width | $t_{CS}$ | | 45 | 45 | ns min |
| Data Setup | $t_{DS}$ | | 30 | 15 | ns min |
| Data Hold | $t_{DH}$ | | 20 | 5 | ns min |
| Reset Pulse Width | $t_{RS}$ | | 40 | 30 | ns min |
| AC CHARACTERISTICS | | | | | |
| Output Slew Rate | SR | Data = 0x000 to 0xFFF to 0x000 | 0.05 | 0.05 | V/µs typ |
| Settling Time[6] | $t_S$ | To ±0.1% of full scale | 70 | 60 | µs typ |
| Shutdown Recovery Time | $t_{SDR}$ | | | 80 | µs typ |
| DAC Glitch | | Code 0x7FF to Code 0x800 to Code 0x7FF | 65 | 65 | nV/s typ |
| Digital Feedthrough | | | 15 | 15 | nV/s typ |
| Feedthrough | $V_{OUT}/V_{REF}$ | $V_{REF}$ = 1.5 V dc + 1 V p-p, data = 0x000, f = 100 kHz | −63 | −63 | dB typ |
| SUPPLY CHARACTERISTICS | | | | | |
| Power Supply Range | $V_{DD\ RANGE}$ | DNL < ±1 LSB | 2.7/5.5 | 2.7/5.5 | V min/max |
| Positive Supply Current | $I_{DD}$ | $V_{IL}$ = 0 V, no load | 55/100 | 55/100 | µA typ/max |
| Shutdown Supply Current | $I_{DD-SD}$ | $\overline{SHDN}$ = 0, $V_{IL}$ = 0 V, no load | 0.1/1.5 | 0.1/1.5 | µA typ/max |
| Power Dissipation | $P_{DISS}$ | $V_{IL}$ = 0 V, no load | 300 | 500 | µW max |
| Power Supply Sensitivity | PSS | Δ $V_{DD}$ = ±5% | 0.006 | 0.006 | %/% max |

[1] One LSB = $V_{REF}$/4096 V for the 12-bit AD7392.
[2] The first two codes (0x000, 0x001) are excluded from the linearity error measurement.
[3] These parameters are guaranteed by design and not subject to production testing.
[4] Typicals represent average readings measured at +25°C.
[5] All input control signals are specified with $t_R$ = $t_F$ = 2 ns (10% to 90% of 13 V) and timed from a voltage level of 1.6 V.
[6] The settling time specification does not apply for negative going transitions within the last 3 LSBs of ground.

At $V_{REF}$ = 2.5 V, −40°C < $T_A$ < +85°C, unless otherwise noted.

**Table 2. AD7393**

| Parameter | Symbol | Conditions | 3 V ± 10% | 5 V ± 10% | Unit |
|---|---|---|---|---|---|
| STATIC PERFORMANCE | | | | | |
| Resolution[1] | N | | 10 | 10 | Bits |
| Relative Accuracy[2] | INL | $T_A$ = +25°C | ±1.75 | ±1.75 | LSB max |
| | | $T_A$ = −40°C, +85°C, +125°C | ±2.0 | ±2.0 | LSB max |
| Differential Nonlinearity[2] | DNL | Monotonic | ±0.8 | ±0.8 | LSB max |
| Zero-Scale Error | $V_{ZSE}$ | Data = 0x000 | 9.0 | 9.0 | mV max |
| Full-Scale Voltage Error | $V_{FSE}$ | $T_A$ = +25°C, +85°C, +125°C, data = 0x3FF | ±32 | ±32 | mV max |
| | | $T_A$ = −40°C, data = 0x3FF | ±42 | ±42 | mV max |
| Full-Scale Temperature Coefficient[3] | $TCV_{FS}$ | | 28 | 28 | ppm/°C typ |
| REFERENCE INPUT | | | | | |
| $V_{REF\ IN}$ Range | $V_{REF}$ | | 0/$V_{DD}$ | 0/$V_{DD}$ | V min/max |
| Input Resistance | $R_{REF}$ | | 2.5 | 2.5 | MΩ typ[4] |
| Input Capacitance[3] | $C_{REF}$ | | 5 | 5 | pF typ |
| ANALOG OUTPUT | | | | | |
| Output Current (Source) | $I_{OUT}$ | Data = 0x200, Δ $V_{OUT}$ = 5 LSB | 1 | 1 | mA typ |
| Output Current (Sink) | $I_{OUT}$ | Data = 0x200, Δ $V_{OUT}$ = 5 LSB | 3 | 3 | mA typ |
| Capacitive Load[3] | $C_L$ | No oscillation | 100 | 100 | pF typ |
| LOGIC INPUTS | | | | | |
| Logic Input Low Voltage | $V_{IL}$ | | 0.5 | 0.8 | V max |
| Logic Input High Voltage | $V_{IH}$ | | $V_{DD}$ − 0.6 | $V_{DD}$ − 0.6 | V min |
| Input Leakage Current | $I_{IL}$ | | 10 | 10 | µA max |
| Input Capacitance[3] | $C_{IL}$ | | 10 | 10 | pF max |
| INTERFACE TIMING[3, 5] | | | | | |
| Chip Select Write Width | $t_{CS}$ | | 45 | 45 | ns |
| Data Setup | $t_{DS}$ | | 30 | 15 | ns |
| Data Hold | $t_{DH}$ | | 20 | 5 | ns |
| Reset Pulse Width | $t_{RS}$ | | 40 | 30 | ns |
| AC CHARACTERISTICS | | | | | |
| Output Slew Rate | SR | Data = 0x000 to 0x3FF to 0x000 | 0.05 | 0.05 | V/µs typ |
| Settling Time[6] | $t_S$ | To ±0.1% of full scale | 70 | 60 | µs typ |
| Shutdown Recovery Time | $t_{SDR}$ | | | 80 | µs typ |
| DAC Glitch | | Code 0x7FF to Code 0x800 to Code 0x7FF | 65 | 65 | nV/s typ |
| Digital Feedthrough | | | 15 | 15 | nV/s typ |
| Feedthrough | $V_{OUT}/V_{REF}$ | $V_{REF}$ = 1.5 V dc 11 V p-p, data = 0x000, f = 100 kHz | −63 | −63 | dB typ |
| SUPPLY CHARACTERISTICS | | | | | |
| Power Supply Range | $V_{DD\ RANGE}$ | DNL < ±1 LSB | 2.7/5.5 | 2.7/5.5 | V min/max |
| Positive Supply Current | $I_{DD}$ | $V_{IL}$ = 0 V, no load, $T_A$ = +25°C | 55 | 55 | µA typ |
| | | $V_{IL}$ = 0 V, no load | 100 | 100 | µA max |
| Shutdown Supply Current | $I_{DD-SD}$ | $\overline{SHDN}$ = 0, $V_{IL}$ = 0 V, no load | 0.1/1.5 | 0.1/1.5 | µA typ/max |
| Power Dissipation | $P_{DISS}$ | $V_{IL}$ = 0 V, no load | 300 | 500 | µW max |
| Power Supply Sensitivity | PSS | Δ $V_{DD}$ = ±5% | 0.006 | 0.006 | %/% max |

[1] One LSB = $V_{REF}$/1024 V for the 10-bit AD7393.
[2] The first two codes (0x000, 0x001) are excluded from the linearity error measurement.
[3] These parameters are guaranteed by design and not subject to production testing.
[4] Typicals represent average readings measured at +25°C.
[5] All input control signals are specified with $t_R$ = $t_F$ = 2 ns (10% to 90% of 13 V) and timed from a voltage level of 1.6 V.
[6] The settling time specification does not apply for negative going transitions within the last 3 LSBs of ground.
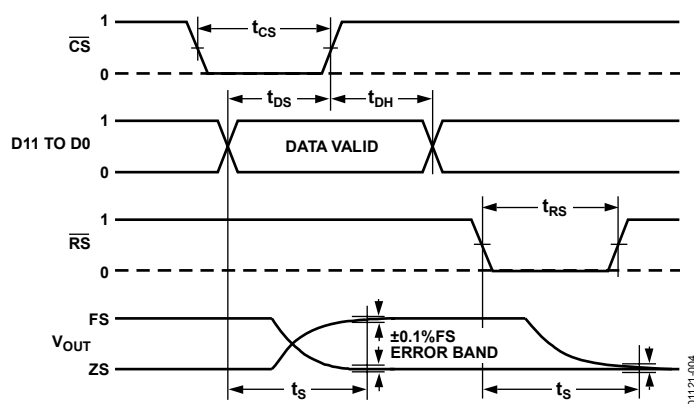
## TIMING DIAGRAM



*Figure 2. Timing Diagram*

## ABSOLUTE MAXIMUM RATINGS

**Table 3.**

| Parameter | Rating |
|---|---|
| $V_{DD}$ to GND | −0.3 V, +8 V |
| $V_{REF}$ to GND | −0.3 V, $V_{DD}$ |
| Logic Inputs to GND | −0.3 V, $V_{DD}$ + 0.3 V |
| $V_{OUT}$ to GND | −0.3 V, $V_{DD}$ + 0.3 V |
| $I_{OUT}$ Short Circuit to GND | 50 mA |
| DGND to AGND | −0.3 V, +2 V |
| Package Power Dissipation | $(T_J \text{ max} - T_A)/\theta_{JA}$ |
| Thermal Resistance ($\theta_{JA}$) | |
| 20-Lead PDIP (N 20) | 57°C/W |
| 20-Lead SOIC (R-20) | 60°C/W |
| Maximum Junction Temperature ($T_J$ max) | 150°C |
| Operating Temperature Range | −40°C to +85°C |
| AD7393AR | −40°C to +125°C |
| Storage Temperature Range | −65°C to +150°C |
| Lead Temperature | |
| Reflow Soldering Peak Temperature | |
| SnPb | 240°C |
| Pb-Free | 260°C |

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### ESD CAUTION

**ESD (electrostatic discharge) sensitive device.** Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.
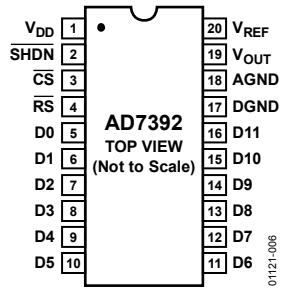
# PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS
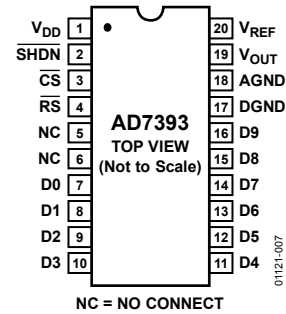


Figure 3. AD7392 Pin Configuration



NC = NO CONNECT

Figure 4. AD7393 Pin Configuration

**Table 4. AD7392 Pin Function Descriptions**

| Pin No. | Mnemonic | Description |
|---------|----------|-------------|
| 1 | $V_{DD}$ | Positive Power Supply Input. The specified range of operation is 2.7 V to 5.5 V. |
| 2 | $\overline{SHDN}$ | Power Shutdown Active Low Input. DAC register contents are saved as long as power stays on the $V_{DD}$ pin. When $\overline{SHDN}$ = 0, $\overline{CS}$ strobes write new data into the DAC register. |
| 3 | $\overline{CS}$ | Chip Select Latch Enable, Active Low. |
| 4 | $\overline{RS}$ | Asynchronous Active Low Input. Resets the DAC register to 0. |
| 5 to 16 | D0 to D11 | Parallel Input Data Bits. D11 is the MSB; D0 is the LSB. |
| 17 | DGND | Digital Ground. |
| 18 | AGND | Analog Ground. |
| 19 | $V_{OUT}$ | DAC Voltage Output. |
| 20 | $V_{REF}$ | DAC Reference Input. Establishes the DAC full-scale voltage. |

**Table 5. AD7393 Pin Function Descriptions**

| Pin No. | Mnemonic | Description |
|---------|----------|-------------|
| 1 | $V_{DD}$ | Positive Power Supply Input. The specified range of operation is 2.7 V to 5.5 V. |
| 2 | $\overline{SHDN}$ | Power Shutdown Active Low Input. DAC register contents are saved as long as power stays on the $V_{DD}$ pin. When $\overline{SHDN}$ = 0, $\overline{CS}$ strobes write new data into the DAC register. |
| 3 | $\overline{CS}$ | Chip Select Latch Enable, Active Low. |
| 4 | $\overline{RS}$ | Asynchronous Active Low Input. Resets the DAC register to 0. |
| 5, 6 | NC | No Connect. |
| 7 to 16 | D0 to D9 | Parallel Input Data Bits. D9 is the MSB; D0 is the LSB. |
| 17 | DGND | Digital Ground. |
| 18 | AGND | Analog Ground. |
| 19 | $V_{OUT}$ | DAC Voltage Output. |
| 20 | $V_{REF}$ | DAC Reference Input. Establishes the DAC full-scale voltage. |

# TYPICAL PERFORMANCE CHARACTERISTICS
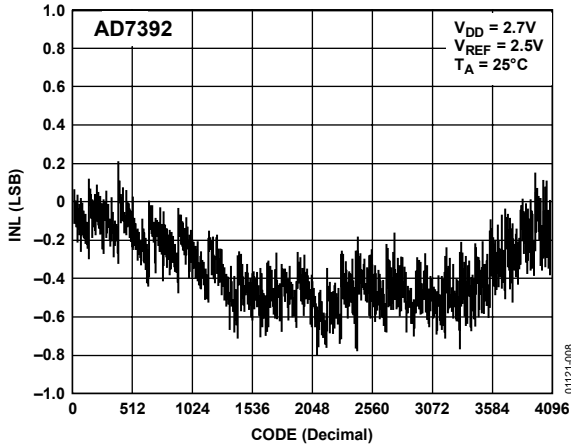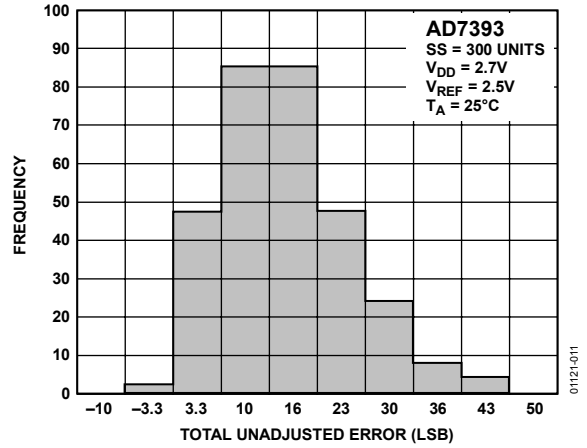


Figure 5. AD7392 Integral Nonlinearity Error vs. Code

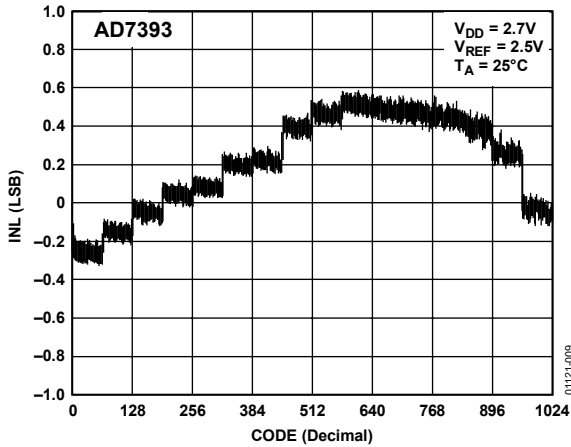

Figure 6. AD7393 Integral Nonlinearity Error vs. Code



Figure 7. AD7392 Total Unadjusted Error Histogram
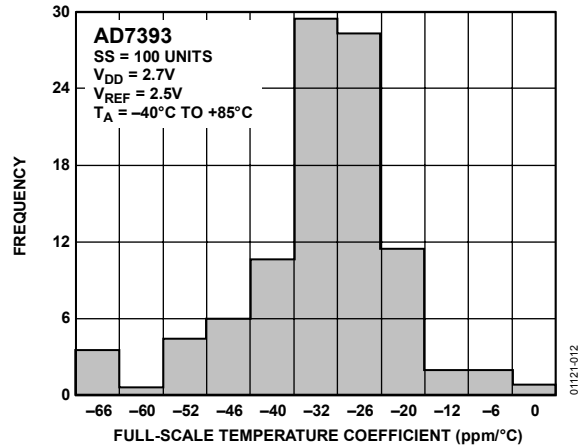


Figure 8. AD7393 Total Unadjusted Error Histogram



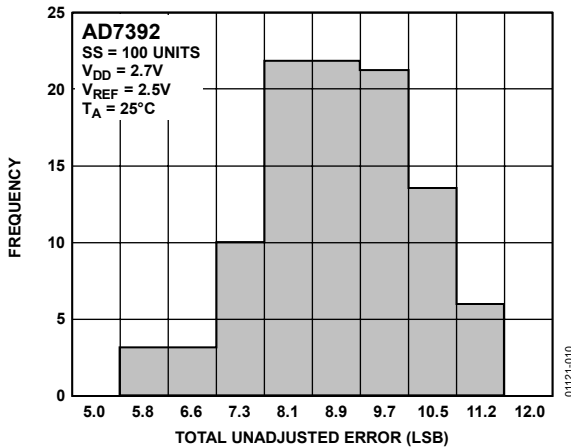Figure 9. AD7393 Full-Scale Output Temperature Coefficient Histogram
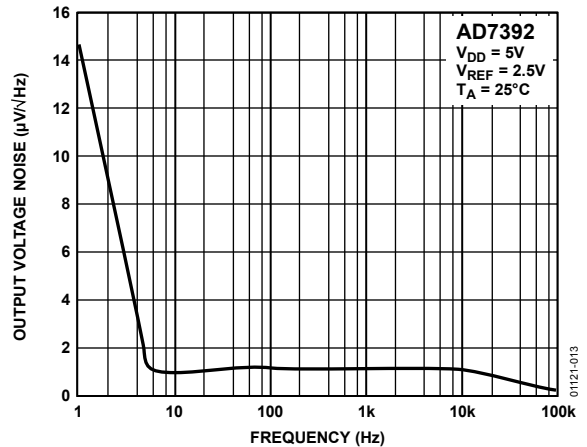


Figure 10. Voltage Noise Density vs. Frequency

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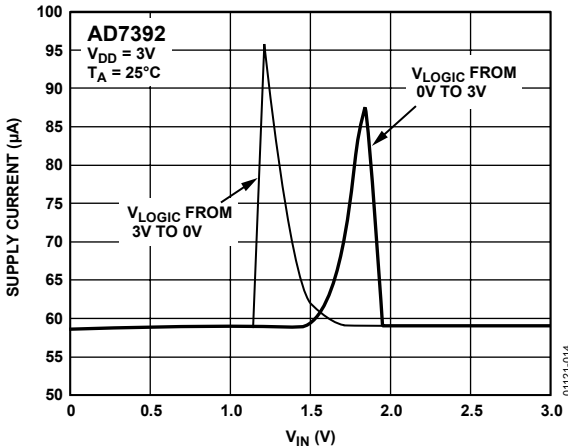
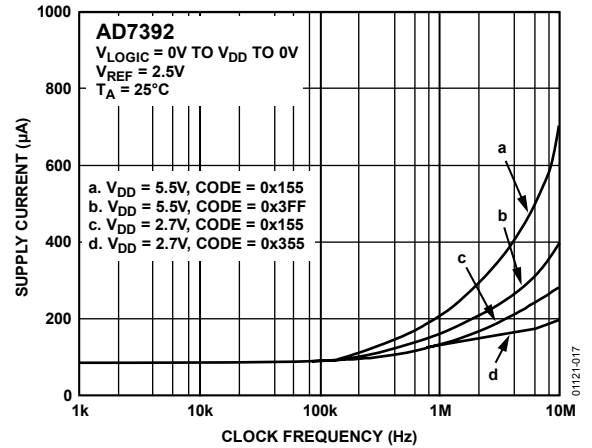Figure 11. Supply Current vs. Logic Input Voltage



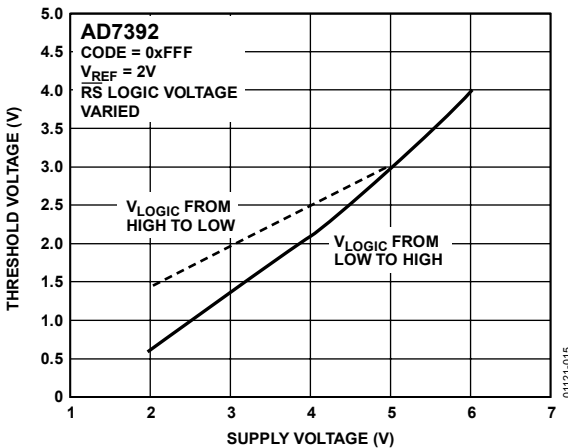Figure 14. Supply Current vs. Clock Frequency



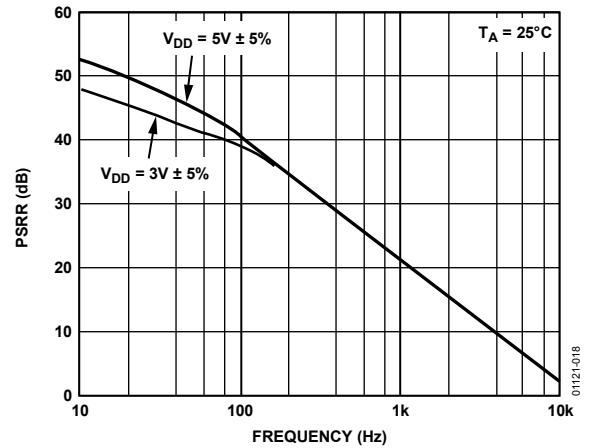Figure 12. Logic Threshold vs. Supply Voltage



Figure 15. Power Supply Rejection Ratio vs. Frequency
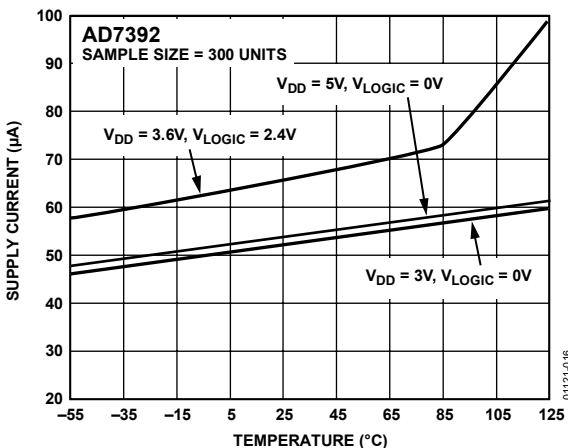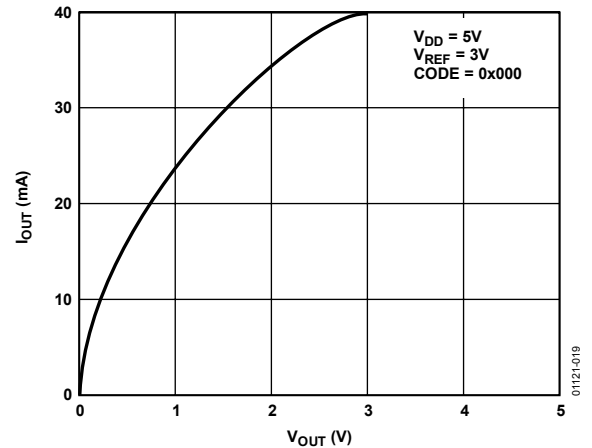


Figure 13. Supply Current vs. Temperature



Figure 16. $I_{OUT}$ at Zero Scale vs. $V_{OUT}$

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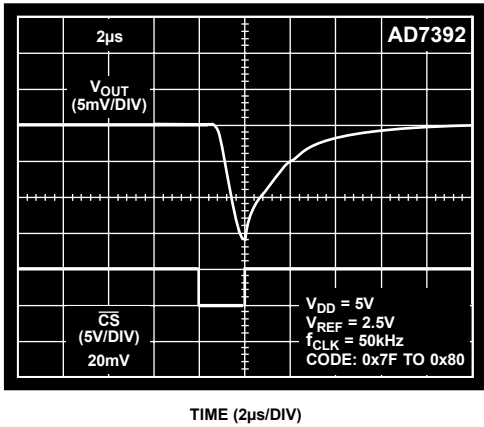
Figure 17. Midscale Transition Performance



Figure 18. Digital Feedthrough



Figure 19. Large Signal Settling Time

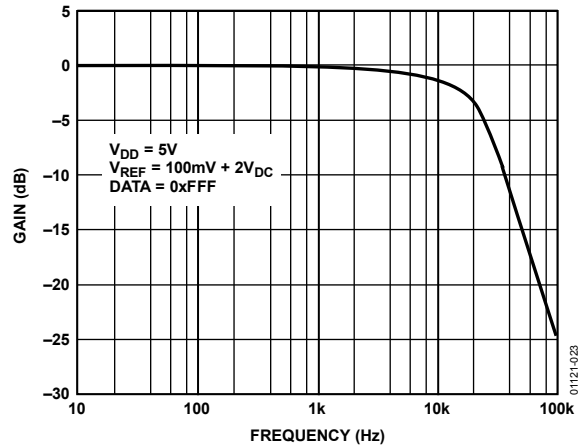

Figure 20. Reference Multiplying Bandwidth



Figure 21. Integral Nonlinearity Error vs. Reference Voltage
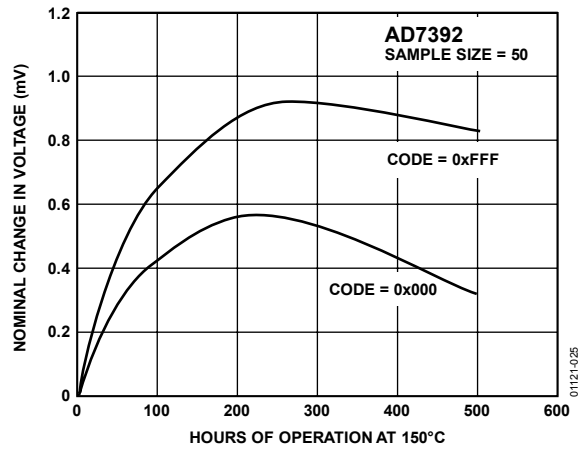


Figure 22. Long-Term Drift Accelerated by Burn-In
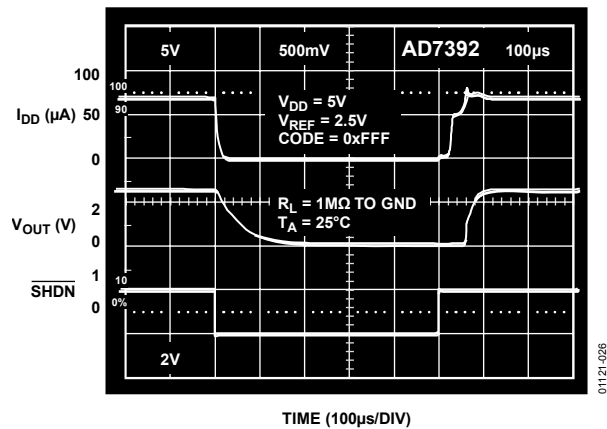
Figure 23. Shutdown Recovery Time



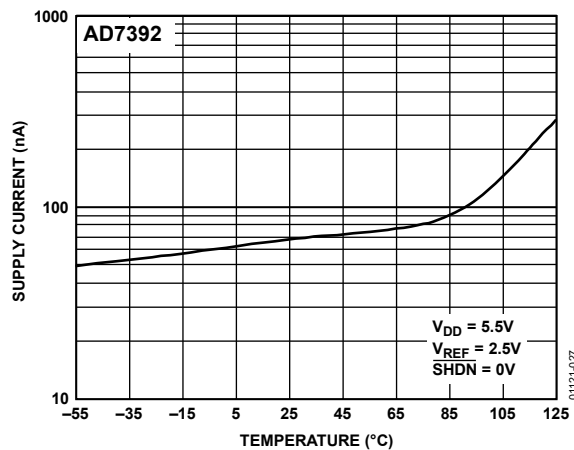Figure 24. Shutdown Current vs. Temperature



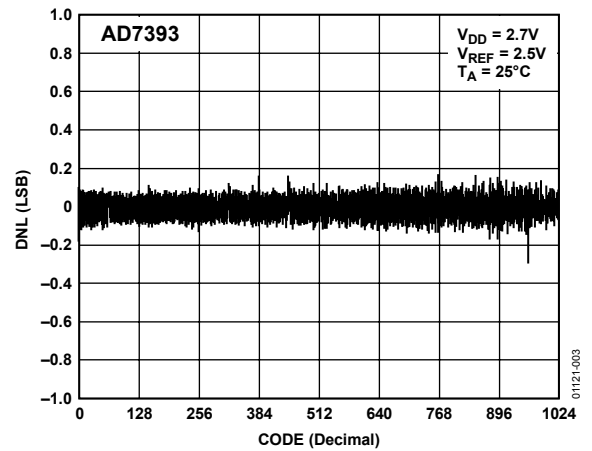Figure 25. AD7392 Differential Nonlinearity Error vs. Code



Figure 26. AD7393 Differential Nonlinearity Error vs. Code

# THEORY OF OPERATION

The AD7392/AD7393 comprise a set of pin-compatible, 12-/10-bit digital-to-analog converters (DACs). These single-supply operation devices consume less than 100 μA of current while operating from 2.7 V to 5.5 V power supplies, making them ideal for battery-operated applications. They contain a voltage-switched, 12-/10-bit, laser-trimmed DAC; rail-to-rail output op amps; and a parallel input DAC register. The external reference input has constant input resistance independent of the digital code setting of the DAC. In addition, the reference input can be tied to the same supply voltage as $V_{DD}$, resulting in a maximum output voltage span of 0 V to $V_{DD}$. The parallel data interface consists of a $\overline{CS}$ write strobe and 12 data bits (D0 to D11) if utilizing the AD7392 or 10 data bits (D0 to D9) if utilizing the AD7393. An $\overline{RS}$ pin is available to reset the DAC register to zero scale. This function is useful for power-on reset or system failure recovery to a known state. Additional power savings are accomplished by activating the $\overline{SHDN}$ pin, resulting in a 1.5 μA maximum consumption sleep mode. While the supply voltage is on, data is retained in the DAC register to reset the DAC output when the part is taken out of shutdown ($\overline{SHDN}$ = 1).

## DIGITAL-TO-ANALOG CONVERTERS

The voltage switched R-2R DAC generates an output voltage that depends on the external reference voltage connected to the $V_{REF}$ pin according to Equation 1.

$$V_{OUT} = V_{REF} \times \frac{D}{2^N} \tag{1}$$

where:
$D$ is the decimal data-word loaded into the DAC register.
$N$ is the number of bits of DAC resolution.

If the 10-bit AD7393 uses a 2.5 V reference, Equation 1 becomes

$$V_{OUT} = 2.5 \times \frac{D}{1024} \tag{2}$$

Using Equation 2, the nominal midscale voltage at $V_{OUT}$ is 1.25 V, for $D$ = 512; full-scale voltage is 2.497 V. The LSB step size is 2.5 × 1/1024 = 0.0024 V.

If the 12-bit AD7392 uses a 5.0 V reference, Equation 1 becomes

$$V_{OUT} = V_{REF} \times \frac{D}{4096} \tag{3}$$

Using Equation 3, the AD7392 provides a nominal midscale voltage of 2.50 V (for $D$ = 2048) and a full-scale $V_{OUT}$ of 4.998 V. The LSB step size is 5.0 × 1/4096 = 0.0012 V.

## AMPLIFIER SECTION

The internal DACs output is buffered by a low power consumption precision amplifier. The op amp has a 60 μs typical settling time to 0.1% of full scale. There are slight differences in settling time for negative slew signals vs. positive. Also, negative transition settling time to within the last 6 LSBs of 0 V has an extended settling time. The rail-to-rail output stage of this amplifier has been designed to provide precision performance while operating near either power supply. Figure 27 shows an equivalent output schematic of the rail-to-rail amplifier with its N-channel pull-down FETs that pull an output load directly to GND. The output sourcing current is provided by a P-channel, pull-up device that can source current-to-GND terminated loads.
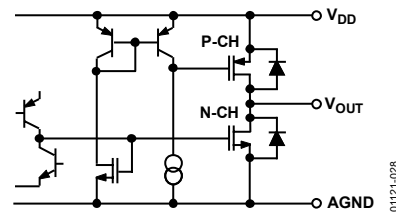

Figure 27. Equivalent Analog Output Circuit

The rail-to-rail output stage provides ±1 mA of output current. The N-channel output pull-down MOSFET, shown in Figure 27, has a 35 Ω on resistance that sets the sink current capability near ground. In addition to resistive load driving capability, the amplifier also has been carefully designed and characterized for up to 100 pF capacitive load driving capability.

## REFERENCE INPUT

The reference input terminal has a constant input resistance independent of digital code, which results in reduced glitches on the external reference voltage source. The high 2.5 MΩ input resistance minimizes power dissipation within the AD7392/AD7393 DACs. The $V_{REF}$ input accepts input voltages ranging from ground to the positive supply voltage $V_{DD}$. One of the simplest applications for saving an external reference voltage source is connecting the REF terminal to the positive $V_{DD}$ supply. This connection results in a rail-to-rail voltage output span maximizing the programmed range. The reference input accepts ac signals as long as they stay within the 0 V < $V_{REF}$ < $V_{DD}$ supply voltage range. The reference bandwidth and integral nonlinearity error performance are plotted in Figure 20 and Figure 21. The ratiometric reference feature makes the AD7392/AD7393 an ideal companion to ratiometric analog-to-digital converters (ADCs) such as the AD7896.

## POWER SUPPLY

The very low power consumption of the AD7392/AD7393 is a direct result of a circuit design that optimizes the CBCMOS process. By using the low power characteristics of CMOS for the logic and the low noise, tight-matching of the complementary bipolar transistors, excellent analog accuracy is achieved. One advantage of the rail-to-rail output amplifiers used in the AD7392/AD7393 is the wide range of usable supply voltage. The part is fully specified and tested for operation from 2.7 V to 5.5 V.
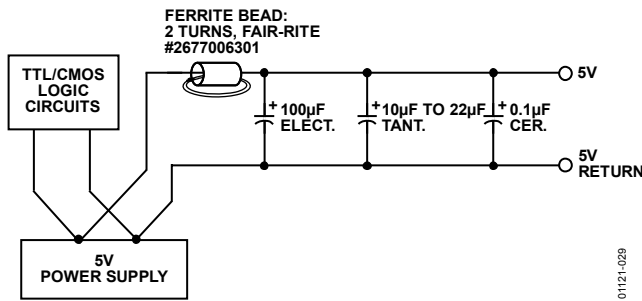


Figure 28. Use Separate Traces to Reduce Power Supply Noise

Whether or not a separate power supply trace is available, generous supply bypassing reduces supply line induced errors. Local supply bypassing, consisting of a 10 μF tantalum electrolytic in parallel with a 0.1 μF ceramic capacitor, is recommended for all applications (see Figure 29).
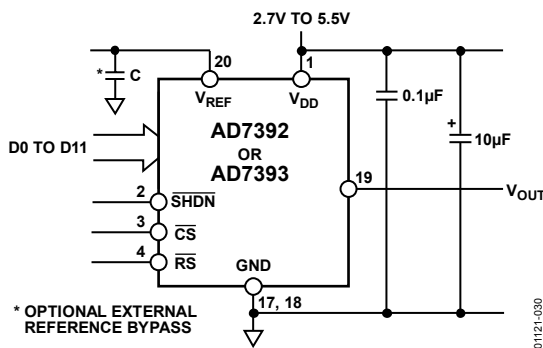


Figure 29. Recommended Supply Bypassing for the AD7392/AD7393

## INPUT LOGIC LEVELS

All digital inputs are protected with a Zener-type ESD protection structure that allows logic input voltages to exceed the $V_{DD}$ supply voltage (see Figure 30). This feature is useful if the user is driving one or more of the digital inputs with a 5 V CMOS logic input voltage level while operating the AD7392/AD7393 on a 3 V power supply. If this interface is used, make sure that the $V_{OL}$ of the 5 V CMOS meets the $V_{IL}$ input requirement of the AD7392/AD7393 operating at 3 V. See Figure 12 for a graph of digital logic input threshold vs. operating $V_{DD}$ supply voltage.
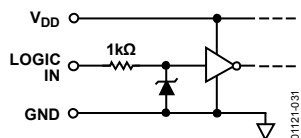


Figure 30. Equivalent Digital Input ESD Protection

To minimize power dissipation from input logic levels that are near the $V_{IH}$ and $V_{IL}$ logic input voltage specifications, a Schmitt-trigger design was used that minimizes the input buffer current consumption compared to traditional CMOS input stages. Figure 11 is a plot of supply current vs. incremental input voltage, showing that negligible current consumption takes place when logic levels are in their quiescent state. The normal crossover current still occurs during logic transitions. A secondary advantage of this Schmitt trigger is the prevention of false triggers that would occur with slow moving logic transitions when a standard CMOS logic interface or opto-isolators are used. Logic inputs D11 to D0, $\overline{CS}$, $\overline{RS}$, and $\overline{SHDN}$ all contain the Schmitt-trigger circuits.

## DIGITAL INTERFACE

The AD7392/AD7393 have a parallel data input. A functional block diagram of the digital section is shown in Figure 31, while Table 6 contains the truth table for the logic control inputs. The chip select pin ($\overline{CS}$) controls loading of data from the data inputs on Pin D11 to Pin D0. This active low input places the input register into a transparent state allowing the data inputs to directly change the DAC ladder values. When $\overline{CS}$ returns to logic high within the data setup-and-hold time specifications, the new value of data in the input register are latched. See Table 6 for a complete listing of conditions.
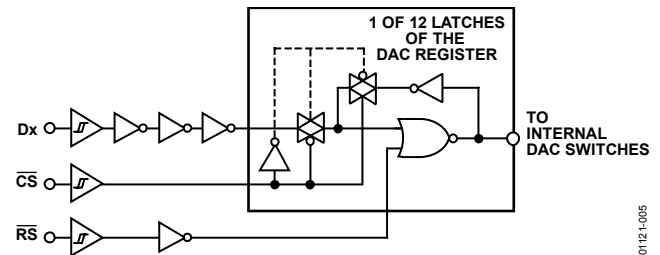


Figure 31. Digital Control Logic

**Table 6. Control Logic Truth Table**

| $\overline{CS}$ | $\overline{RS}$ | DAC Register Function |
|---|---|---|
| H | H | Latched |
| L | H | Transparent |
| ↑[1] | H | Latched with new data |
| X[2] | L | Loaded with all zeros |
| H | ↑[1] | Latched all zeros |

[1] ↑ = Positive logic transition.
[2] X = Don't care.

## RESET PIN ($\overline{\text{RS}}$)

Forcing the asynchronous $\overline{\text{RS}}$ pin low sets the DAC register to all 0s, so the DAC output voltage is 0 V. The reset function is useful for setting the DAC outputs to 0 at power-up or after a power supply interruption. Test systems and motor controllers are two of many applications that benefit from powering up to a known state. The external reset pulse can be generated by three methods:

- The microprocessor's power-on RESET signal

- An output from the microprocessor

- An external resistor and capacitor

RESET has a Schmitt-trigger input, which results in a clean reset function when using external resistor-/capacitor-generated pulses (see Table 6).

## POWER SHUTDOWN ($\overline{\text{SHDN}}$)

Maximum power savings can be achieved by using the power shutdown control function. This hardware-activated feature is controlled by the active low input $\overline{\text{SHDN}}$ pin. This pin has a Schmitt-trigger input that helps desensitize it to slowly changing inputs. Setting this pin to logic low reduces the internal consumption of the AD7392/AD7393 to nanoamp levels, guaranteed to 1.5 µA maximum over the operating temperature range. If power is present at all times on the $V_{DD}$ pin while in shutdown mode, the internal DAC register retains the last programmed data value. The digital interface is still active in shutdown so that code changes can be made that produce new DAC settings when the device is taken out of shutdown. This data is used when the part is returned to the normal active state by placing the DAC back to its programmed voltage setting. Figure 23 shows a plot of shutdown recovery time with both $I_{DD}$ and $V_{OUT}$ displayed. In the shutdown state, the DAC output amplifier exhibits an open-circuit high resistance state. Any load that is connected stabilizes at its termination voltage. If the power shutdown feature is not needed, the user should tie the $\overline{\text{SHDN}}$ pin to the $V_{DD}$ voltage to disable this function.

## UNIPOLAR OUTPUT OPERATION

This is the basic mode of operation for the AD7392. The AD7392 is designed to drive loads as low as 5 kΩ in parallel with 100 pF (see Figure 32). The code table for this operation is shown in Table 7.

The circuit can be configured with an external reference plus power supply or powered from a single dedicated regulator or reference depending on the application performance requirements.
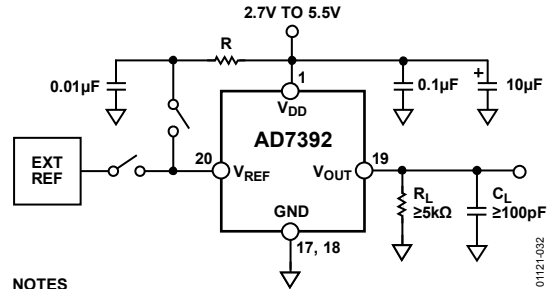


NOTES
1. DIGITAL INTERFACE CIRCUITRY OMITTED FOR CLARITY

Figure 32. AD7392 Unipolar Output Operation

**Table 7. Unipolar Code Table**

| DAC Register No. | | |
|---|---|---|
| **Hexadecimal** | **Decimal** | **Output Voltage (V), $V_{REF}$ = 2.5 V** |
| 0xFFF | 4095 | 2.4994 |
| 0x801 | 2049 | 1.2506 |
| 0x800 | 2048 | 1.2500 |
| 0x7FF | 2047 | 1.2494 |
| 0x000 | 0 | 0 |

## BIPOLAR OUTPUT OPERATION

Although the AD7393 is designed for single-supply operation, the output can be easily configured for bipolar operation. A typical circuit is shown in Figure 33. This circuit uses a clean, regulated 5 V supply for power, which also provides the circuit's reference voltage. Since the AD7393 output span swings from ground to very near 5 V, it is necessary to choose an external amplifier with a common-mode input voltage range that extends to its positive supply rail. The micropower consumption OP196 is designed just for this purpose and results in only 50 μA of maximum current consumption. Connecting the two 470 kΩ resistors results in a differential amplifier mode of operation with a voltage gain of 2, which produces a circuit output span of 10 V, that is, −5 V to +5 V. As the DAC is programmed from zero-code 0x000 to midscale 0x200 to full scale 0x3FF, the circuit output voltage, $V_O$, is set at −5 V, 0 V, and +5 V (minus 1 LSB). The output voltage, $V_O$, is coded in offset binary according to Equation 4.

$$V_O = \left[\frac{D}{512} - 1\right] \times 5 \qquad (4)$$

where $D$ is the decimal code loaded in the AD7393 DAC register.

Note that the LSB step size is 10/1024 = 10 mV. This circuit is optimized for micropower consumption including the 470 kΩ gain setting resistors, which should have low temperature coefficients to maintain accuracy and matching (preferably the same resistor material, such as metal film).

If better stability is required, the power supply may be substituted with a precision reference voltage such as the low dropout REF195, which can easily supply the circuit's 162 μA of current, and still provide additional power for the load connected to $V_O$. The micropower REF195 is guaranteed to source 10 mA output drive current, but consumes only 50 μA internally.

If higher resolution is required, the AD7392 can be used with two additional bits of data inserted into the software coding, which results in a 2.5 mV LSB step size. Table 8 shows examples of nominal output voltages ($V_O$) provided by the bipolar operation circuit application.
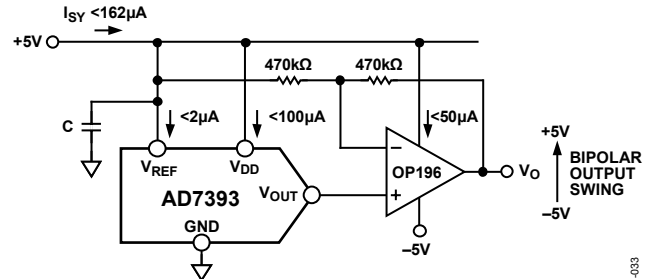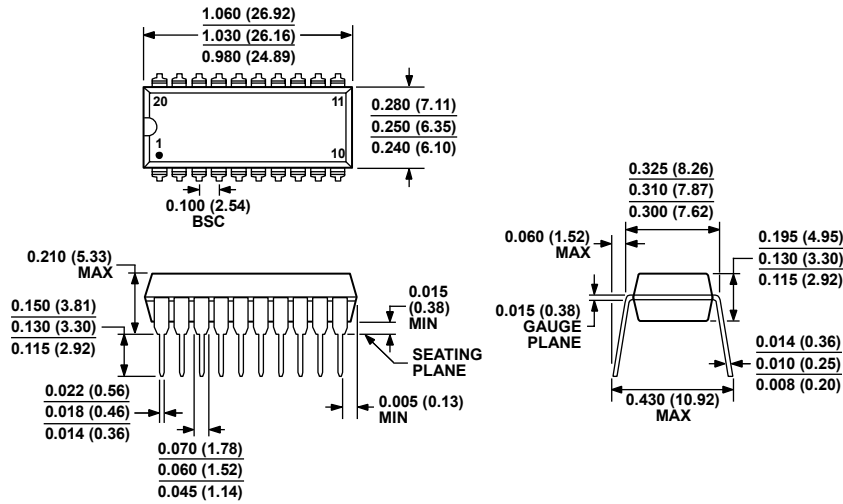


**NOTES**
**1. DIGITAL INTERFACE CIRCUITRY OMITTED FOR CLARITY**

*Figure 33. Bipolar Output Operation*

**Table 8. Bipolar Code Table**

| DAC Register No. | | |
|---|---|---|
| **Hexadecimal** | **Decimal** | **Analog Output Voltage (V)** |
| 0x3FF | 1023 | +4.9902 |
| 0x201 | 513 | +0.0097 |
| 0x200 | 512 | 0.0000 |
| 0x1FF | 511 | −0.0097 |
| 0x000 | 0 | −5.0000 |

## OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MS-001

CONTROLLING DIMENSIONS ARE IN INCHES; MILLIMETER DIMENSIONS
(IN PARENTHESES) ARE ROUNDED-OFF INCH EQUIVALENTS FOR
REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.
CORNER LEADS MAY BE CONFIGURED AS WHOLE OR HALF LEADS.

*Figure 34. 20-Lead Plastic Dual In-Line Package [PDIP]*
*Narrow Body*
*(N-20)*
*Dimensions shown in inches and (millimeters)*
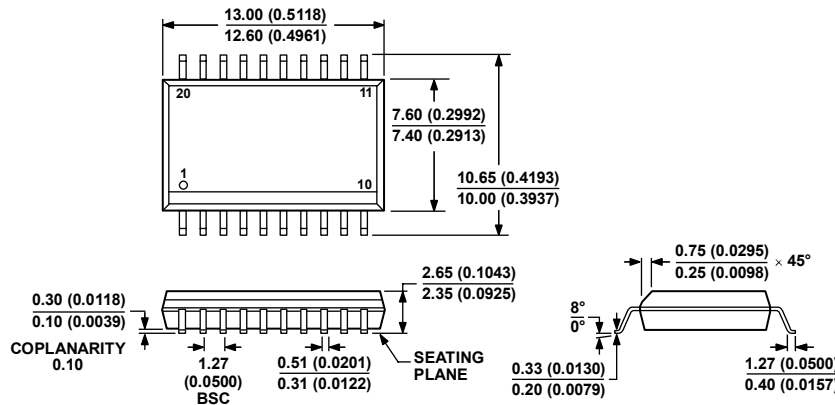


COMPLIANT TO JEDEC STANDARDS MS-013-AC

CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS
(IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR
REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

*Figure 35. 20-Lead Standard Small Outline Package [SOIC_W]*
*Wide Body*
*(RW-20)*
*Dimensions shown in millimeters and (inches)*

## ORDERING GUIDE

| Model | Resolution (Bits) | Temperature Range | Package Description | Package Option |
|---|---|---|---|---|
| AD7392AN | 12 | −40°C to +85°C | 20-Lead PDIP | N-20 |
| AD7392ANZ[1] | 12 | −40°C to +85°C | 20-Lead PDIP | N-20 |
| AD7392AR | 12 | −40°C to +85°C | 20-Lead SOIC_W | RW-20 |
| AD7392AR-REEL | 12 | −40°C to +85°C | 20-Lead SOIC_W | RW-20 |
| AD7392ARZ[1] | 12 | −40°C to +85°C | 20-Lead SOIC_W | RW-20 |
| AD7392ARZ-REEL[1] | 12 | −40°C to +85°C | 20-Lead SOIC_W | RW-20 |
| AD7393AN | 10 | −40°C to +85°C | 20-Lead PDIP | N-20 |
| AD7393AR | 10 | −40°C to +125°C | 20-Lead SOIC_W | RW-20 |
| AD7393ARZ[1] | 10 | −40°C to +125°C | 20-Lead SOIC_W | RW-20 |

[1] Z = RoHS Compliant Part.

## NOTES

# NOTES

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